Di Xu

List of Publications by Year in descending order

Source: https://exaly.com/author-pdf/10723275/publications.pdf

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| | 1684188 | 1720034 | |
|----------------|----------------|------------------------------|--|
| 273 | 5 | 7 | |
| citations | h-index | g-index | |
| | | | |
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| | | | |
| 9 | 9 | 238 | |
| docs citations | times ranked | citing authors | |
| | | | |
| | citations 9 | 273 5 citations h-index 9 9 | |

| # | ARTICLE | IF | CITATIONS |
|---|---|-----|-----------|
| 1 | Nanotwin formation in copper thin films by stress/strain relaxation in pulse electrodeposition. Applied Physics Letters, 2007, 91, . | 3.3 | 80 |
| 2 | <i>In situ</i> measurements of stress evolution for nanotwin formation during pulse electrodeposition of copper. Journal of Applied Physics, 2009, 105, . | 2.5 | 71 |
| 3 | Structure and migration of (112) step on (111) twin boundaries in nanocrystalline copper. Journal of Applied Physics, 2008, 104 , . | 2.5 | 57 |
| 4 | Nanotwin formation and its physical properties and effect on reliability of copper interconnects. Microelectronic Engineering, 2008, 85, 2155-2158. | 2.4 | 27 |
| 5 | Modulation of Crystallographic Texture and Twinning Structure of Cu Nanowires by Electrodeposition. Journal of the Electrochemical Society, 2013, 160, D207-D211. | 2.9 | 24 |
| 6 | Electromigration failure with thermal gradient effect in SnAgCu solder joints with various UBM. , 2009, , . | | 10 |
| 7 | Nanotwin-modified copper interconnects and its effect on the physical properties of copper. , 2009, , . | | 0 |